Applicant(s)/Patent Under Application/Control No. Reexamination 10/774,788 SHIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Patrick J. Lee 2878 U.S. PATENT DOCUMENTS Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-6,822,218 B2 11-2004 Helmig et al. 250/227.18 Α В US-С US-D US-US-Ε US-US-G US-Н US-1

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